


<b>Search Notes</b> 	<b>Application/Control No.</b> 10599103	<b>Applicant(s)/Patent Under Reexamination</b> WU ET AL.
	<b>Examiner</b> IQBAL ZAIDI	<b>Art Unit</b> 2464

SEARCHED			
Class	Subclass	Date	Examiner
370	330, 329, 208, 437, 296, 260, 525, 442, 367	5/15/09	IZ
375	260, 264	5/14/09	IZ
455	403, 450, 422	5/15/09	IZ
370	330, 329, 208, 437, 296, 260, 525, 442, 367	06/15/2010	iz
370	328, 329, 330, 331, 332, 333, 334, 335, 336, 337, 338, 437, 229, 330, 331, 332, 333, 334, 347, 348, 469, 470, 471, 343, 344,	12/29/2010	iz
370	329-338, 229, 437, 347-350, 469-473	06/15/2011	iz
455	450-464	06/15/2011	iz

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(See History)	5/15/09	IZ
Tran, Hai 725Invenotr search, Google, IEEE	5/15/09	IZ
EAST(See updated History)	06/15/2010	iz
EAST(See updated History)	12/29/2010	iz
Google, IEEE	12/29/2010	iz
EAST(See updated History)	06/15/2011	iz
Google, IEEE	06/15/2011	iz

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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